

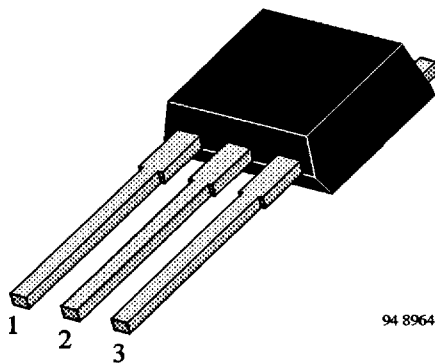
### Silicon NPN High Voltage Switching Transistor

#### Features

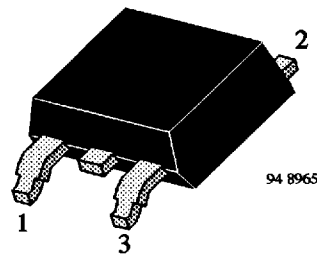
- Multi diffusion technology
- Glass passivation
- High reverse voltage
- Short switching times

#### Applications

Electronic lamp ballast circuits  
Switch-mode power supplies



BUD86  
BUD87  
1 Emitter 2 Collector 3 Base



BUD86 -SMD  
BUD87 -SMD  
1 Emitter 2 Collector 3 Base

#### Absolute Maximum Ratings

$T_{case} = 25^{\circ}C$ , unless otherwise specified

Parameter	Test Conditions	Type	Symbol	Value	Unit
Collector-emitter voltage		BUD86	$V_{CEO}$	400	V
		BUD87	$V_{CEO}$	450	V
		BUD86	$V_{CES}$	800	V
		BUD87	$V_{CES}$	1000	V
Emitter-base voltage			$V_{EBO}$	5	V
Collector current			$I_C$	0.5	A
Collector peak current			$I_{CM}$	1	A
Base current			$I_B$	0.3	A
			$-I_B$	0.3	A
Total power dissipation	$T_{case} \leq 60^{\circ}C$		$P_{tot}$	20	W
Junction temperature			$T_j$	150	$^{\circ}C$
Storage temperature range			$T_{stg}$	-65 to +150	$^{\circ}C$

## Maximum Thermal Resistance

$T_{\text{case}} = 25^{\circ}\text{C}$ , unless otherwise specified

Parameter	Test Conditions	Symbol	Value	Unit
Junction case		$R_{\text{thJC}}$	4.5	K/W

## Electrical Characteristics

$T_{\text{case}} = 25^{\circ}\text{C}$ , unless otherwise specified

Parameter	Test Conditions	Type	Symbol	Min	Typ	Max	Unit
Collector cut-off current	$V_{\text{CE}} = 800 \text{ V}$	BUD86	$I_{\text{CES}}$			100	$\mu\text{A}$
	$V_{\text{CE}} = 1000 \text{ V}$	BUD87	$I_{\text{CES}}$			100	$\mu\text{A}$
	$V_{\text{CE}} = 800 \text{ V}; T_{\text{case}} = 125^{\circ}\text{C}$	BUD86	$I_{\text{CES}}$			1	mA
	$V_{\text{CE}} = 1000 \text{ V}; T_{\text{case}} = 125^{\circ}\text{C}$	BUD87	$I_{\text{CES}}$			1	mA
Collector-emitter breakdown voltage (figure 1)	$I_{\text{C}} = 100 \text{ mA}; L = 125 \text{ mH}; I_{\text{measure}} = 50 \text{ mA}$	BUD86	$V_{(\text{BR})\text{CEO}}$	400			V
		BUD87	$V_{(\text{BR})\text{CEO}}$	450			V
Emitter-base breakdown voltage	$I_{\text{E}} = 1 \text{ mA}$		$V_{(\text{BR})\text{EBO}}$	5			V
Collector-emitter saturation voltage	$I_{\text{C}} = 100 \text{ mA}; I_{\text{B}} = 10 \text{ mA}$		$V_{\text{CEsat}}$			0.8	V
	$I_{\text{C}} = 200 \text{ mA}; I_{\text{B}} = 20 \text{ mA}$		$V_{\text{CEsat}}$			1	V
Base-emitter saturation voltage	$I_{\text{C}} = 200 \text{ mA}; I_{\text{B}} = 20 \text{ mA}$		$V_{\text{BEsat}}$			1	V
DC forward current transfer ratio	$V_{\text{CE}} = 5 \text{ V}; I_{\text{C}} = 50 \text{ mA}$		$h_{\text{FE}}$		50		
Gain bandwidth product	$I_{\text{C}} = 50 \text{ mA}; V_{\text{CE}} = 10 \text{ V}; f = 1 \text{ MHz}$		$f_{\text{T}}$		20		MHz

## Switching Characteristics

$T_{\text{case}} = 25^{\circ}\text{C}$ , unless otherwise specified

Parameter	Test Conditions	Type	Symbol	Min	Typ	Max	Unit
Resistive load (figure 2)							
Storage time	$I_{\text{C}} = 400 \text{ mA}; I_{\text{B1}} = 20 \text{ mA}; -I_{\text{B2}} = 40 \text{ mA}; V_{\text{S}} = 125 \text{ V}$		$t_{\text{s}}$			3.5	$\mu\text{s}$
Fall time			$t_{\text{f}}$		0.4		$\mu\text{s}$

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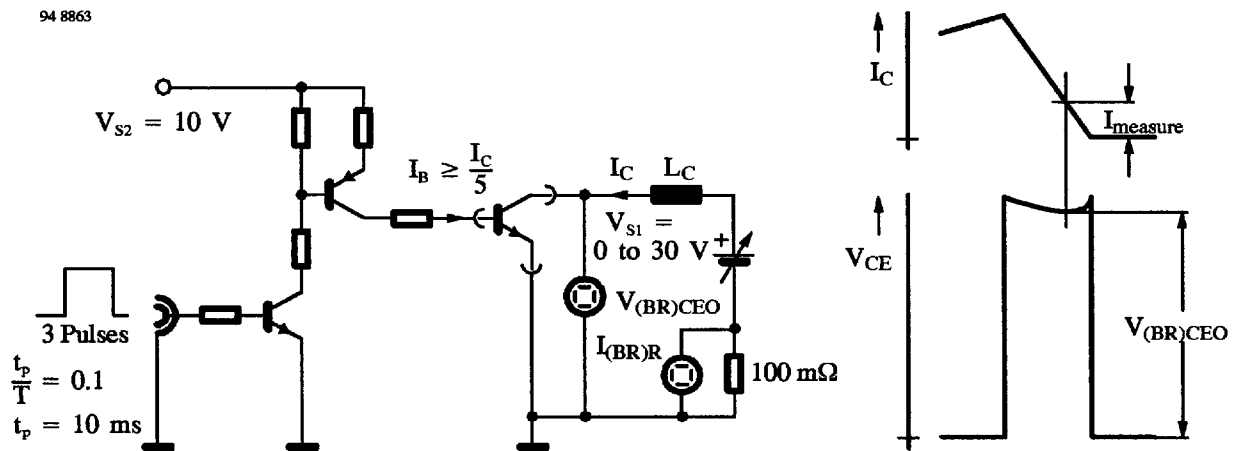
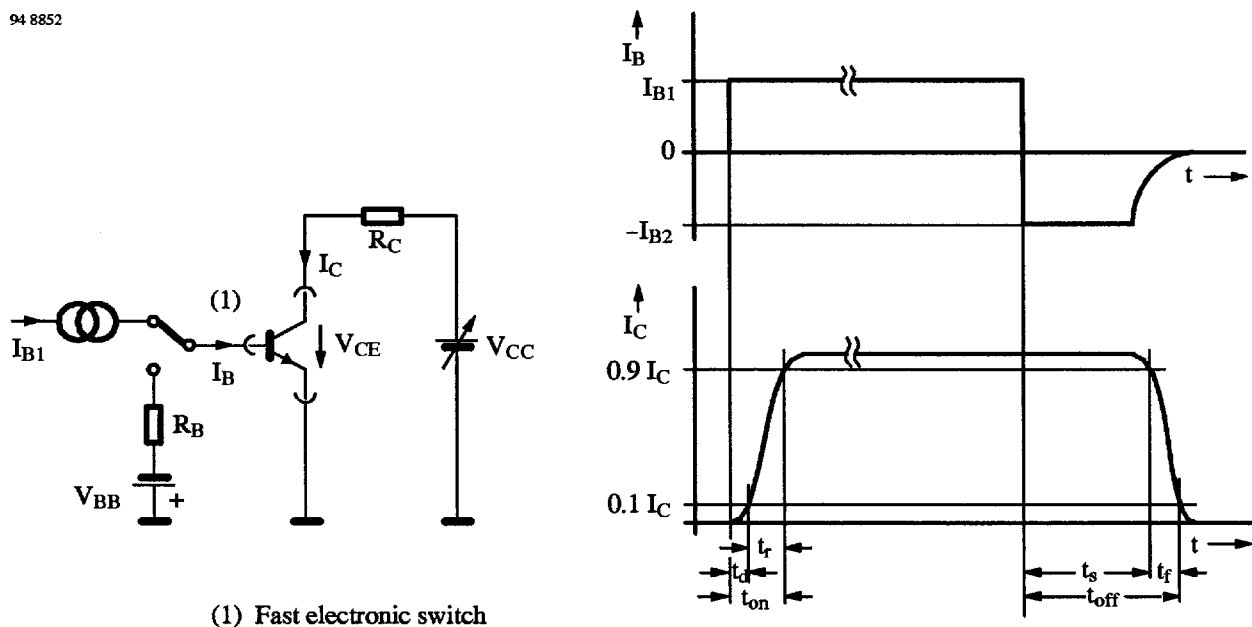


Figure 1. Test circuit for  $V_{(BR)CEO}$

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(1) Fast electronic switch

Figure 2. Test circuit for switching characteristics - resistive load

## Typical Characteristics ( $T_{\text{case}} = 25^\circ\text{C}$ unless otherwise specified)

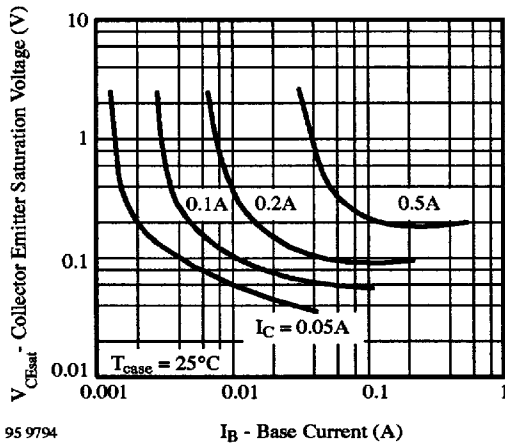


Figure 3.  $V_{\text{CEsat}}$  vs.  $I_B$

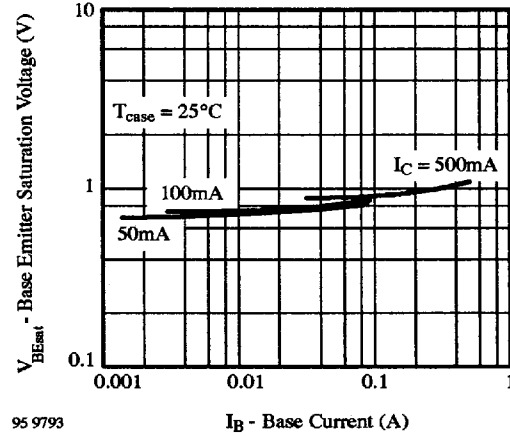


Figure 5.  $V_{\text{BEsat}}$  vs.  $I_B$

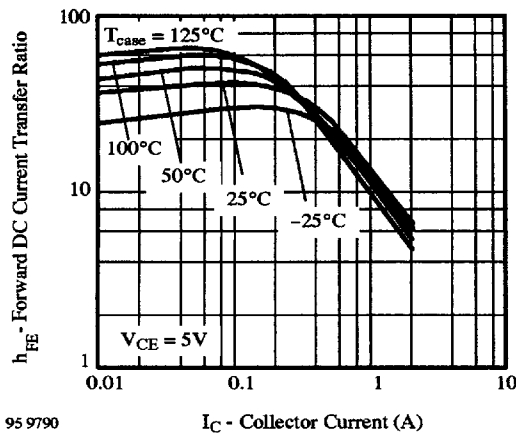


Figure 4.  $h_{\text{FE}}$  vs.  $I_C$

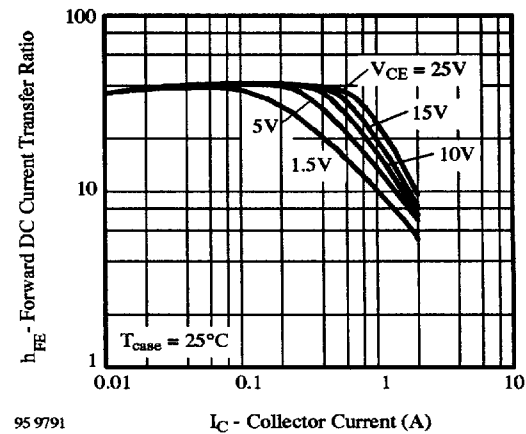
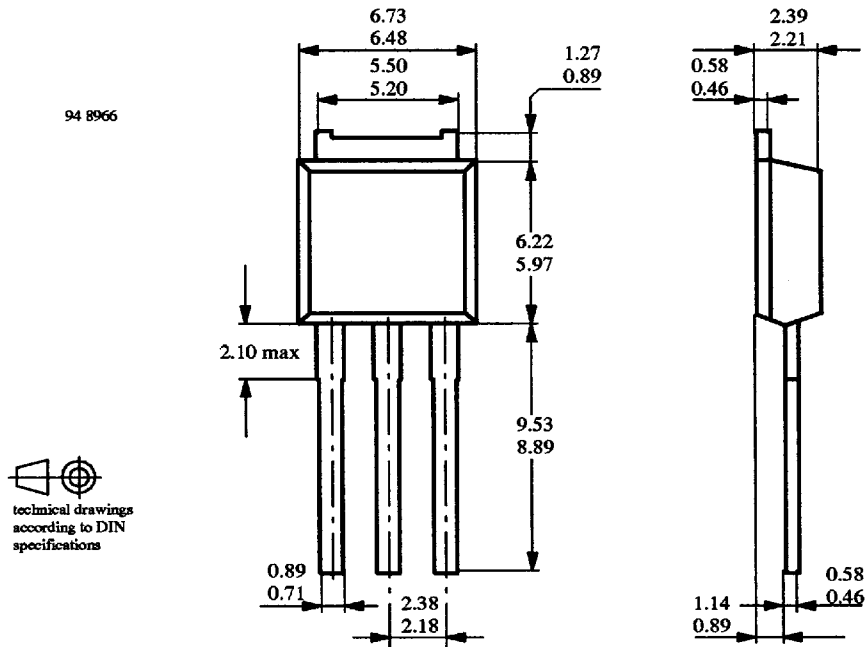


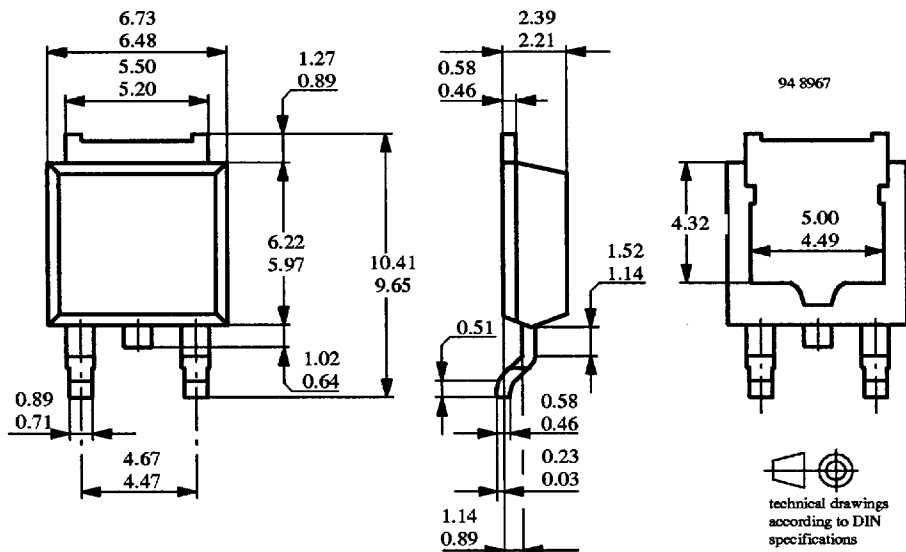
Figure 6.  $h_{\text{FE}}$  vs.  $I_C$

### Dimensions in mm

#### TO251



#### TO252



For ordering TO 252 add SMD to the type number (i.e. BUD86-SMD)